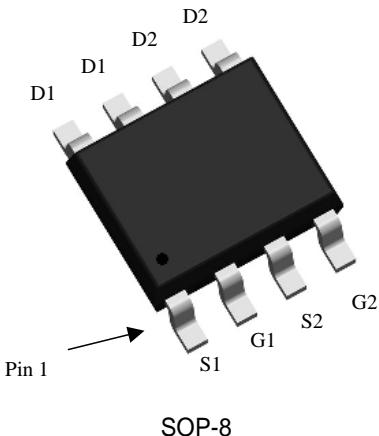


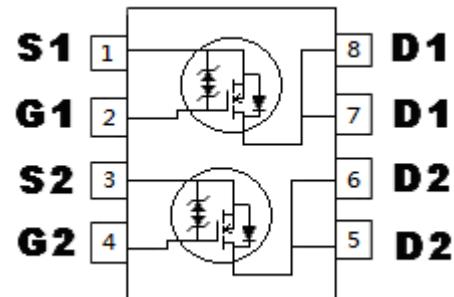
## Dual N-Channel Enhancement Mode Power MOSFET

### Features:

- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Dual N-ch MOSFET package
- ESD protected gate
- Pb-free lead plating & Halogen-free package



<b>BVDSS</b>	<b>100V</b>
<b>ID@VGS=10V, TA=25°C</b>	<b>2.5A</b>
<b>ID@VGS=10V, TA=70°C</b>	<b>2.0A</b>
<b>RDS(on)@VGS=10V, ID=2A</b>	<b>100mΩ (typ)</b>
<b>RDS(on)@VGS=4.5V, ID=2A</b>	<b>119mΩ (typ)</b>



G : Gate D : Drain S : Source

### Ordering Information

Device	Package	Shipping
KSCB100A10KR	SOP-8 (Pb-free lead plating and halogen-free package)	2500 pcs / tape & reel



## Absolute Maximum Ratings ( $T_a=25^\circ C$ )

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	$V_{DS}$	100	<b>V</b>
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current @ $V_{GS}=10V$ , $T_c=25^\circ C$	$I_D$	4.4	<b>A</b>
Continuous Drain Current @ $V_{GS}=10V$ , $T_c=100^\circ C$		2.8	
Continuous Drain Current @ $V_{GS}=10V$ , $T_A=25^\circ C$		2.5 (Note 2)	
Continuous Drain Current @ $V_{GS}=10V$ , $T_A=70^\circ C$		2.0 (Note 2)	
Pulsed Drain Current	$I_{DM}$	16 (Note 1)	<b>mJ</b>
Avalanche Current @ $L=0.1mH$	$I_{AS}$	16	
Avalanche Energy @ $L=1mH$ , $I_D=8A$ , $V_{DD}=25V$	$E_{AS}$	32 (Note 4)	<b>W</b>
Power Dissipation for Dual Operation	$P_D$	2	
Power Dissipation for Single Operation		1.6 (Note 2)	
Operating Junction and Storage Temperature Range		0.9 (Note 3)	
$T_j$ , $T_{stg}$		-55~+150	$^\circ C$

## Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	25	$^\circ C/W$
Thermal Resistance, Junction-to-ambient, max, dual	$R_{\theta JA}$	62.5	
Thermal Resistance, Junction-to-ambient, max, single operation		78 (Note 2)	
		135 (Note 3)	

Note : 1. Pulse width limited by maximum junction temperature  
 2. Surface mounted on 1 in<sup>2</sup>copper pad of FR-4 board, pulse width≤10s.  
 3. Surface mounted on minimum copper pad, pulse width≤10s.  
 4. 100% tested by conditions of  $L=0.1mH$ ,  $V_{GS}=10V$ ,  $I_{AS}=8A$ ,  $V_{DD}=25V$ .

## Characteristics ( $T_j=25^\circ C$ , unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
$BV_{DSS}$	100	-	-	<b>V</b>	$V_{GS}=0V$ , $I_D=250\mu A$
$V_{GS(th)}$	1	-	2.5		$V_{DS}=V_{GS}$ , $I_D=250\mu A$
$G_{FS} *1$	-	5	-	<b>S</b>	$V_{DS}=10V$ , $I_D=3A$
$I_{GSS}$	-	-	$\pm 10$	$\mu A$	$V_{GS}=\pm 16V$ , $V_{DS}=0V$
$ID_{SS}$	-	-	1		$V_{DS}=80V$ , $V_{GS}=0V$
	-	-	25		$V_{DS}=80V$ , $V_{GS}=0V$ , $T_j=70^\circ C$
$R_{DS(ON)} *1$	-	100	130	$m\Omega$	$V_{GS}=10V$ , $I_D=2A$
	-	119	167		$V_{GS}=4.5V$ , $I_D=2A$
<b>Dynamic</b>					
$Q_g *1, 2$	-	7.7	11.6	$nC$	$V_{DS}=50V$ , $I_D=2.5A$ , $V_{GS}=10V$
$Q_{gs} *1, 2$	-	1.5	-		
$Q_{gd} *1, 2$	-	1.3	-		

td(ON) *1, 2	-	6	9	ns	$V_{DS}=50V, I_D=2.5A, V_{GS}=10V, R_G=6\Omega$
tr *1, 2	-	17	25.5		
td(OFF) *1, 2	-	20.4	30.6		
tf *1, 2	-	5.4	8.1		
Ciss	-	389	584	pF	$V_{GS}=0V, V_{DS}=50V, f=1MHz$
Coss	-	29	43.5		
Crss	-	7.7	11.5		
Rg	-	5	-		

### Source-Drain Diode

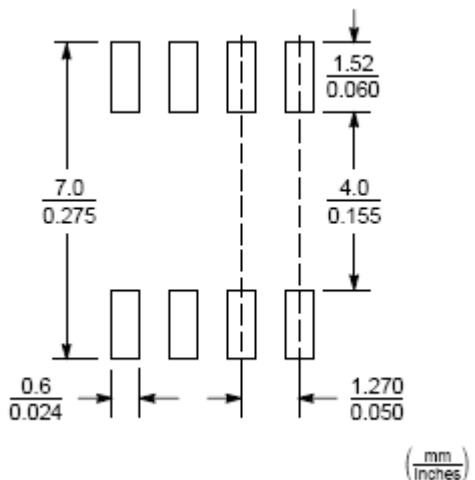
Is *1	-	-	2.5	A	
ISM *3	-	-	10		
VSD *1	-	0.83	1.2	V	$I_S=2A, V_{GS}=0V$
trr *1	-	17.9	-	ns	$I_F=2.5A, dI_F/dt=100A/\mu s$
Qrr *1	-	16.3	-		

Note : \*1.Pulse Test : Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$

\*2.Independent of operating temperature

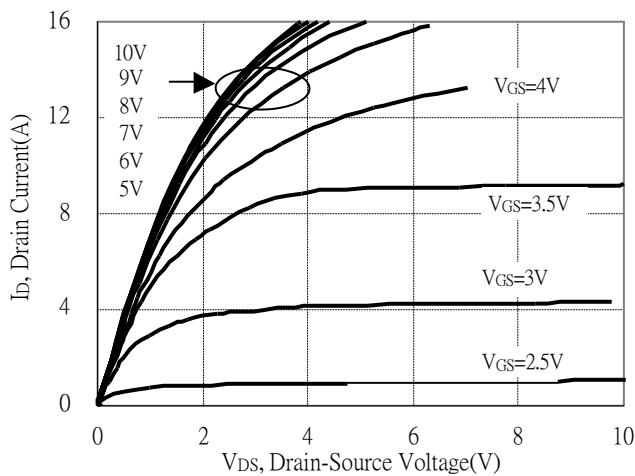
\*3.Pulse width limited by maximum junction temperature.

### Recommended Soldering Footprint

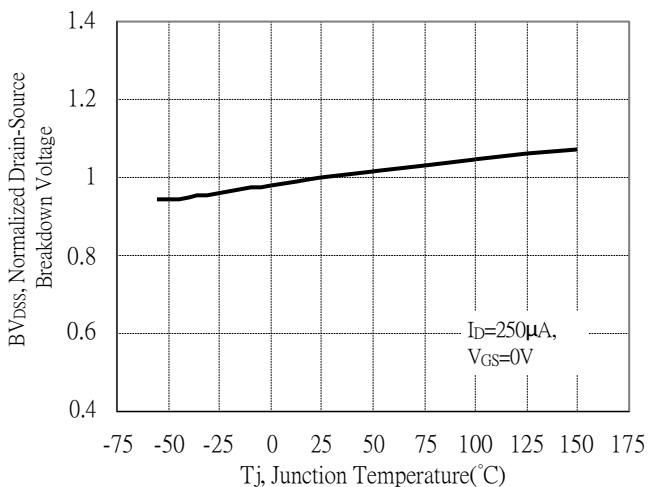


## Typical Characteristics

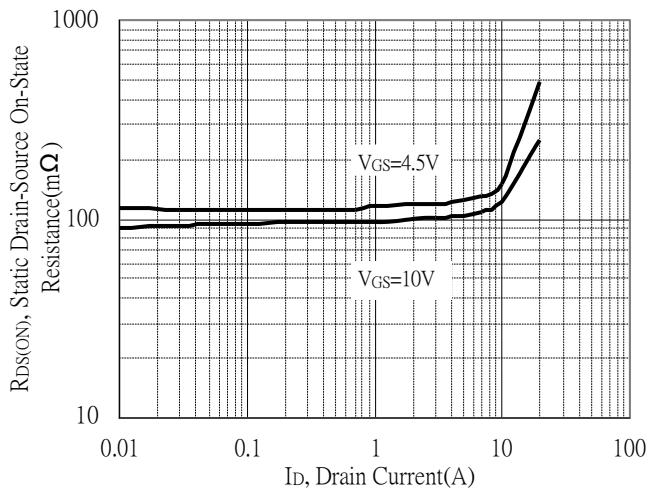
Typical Output Characteristics



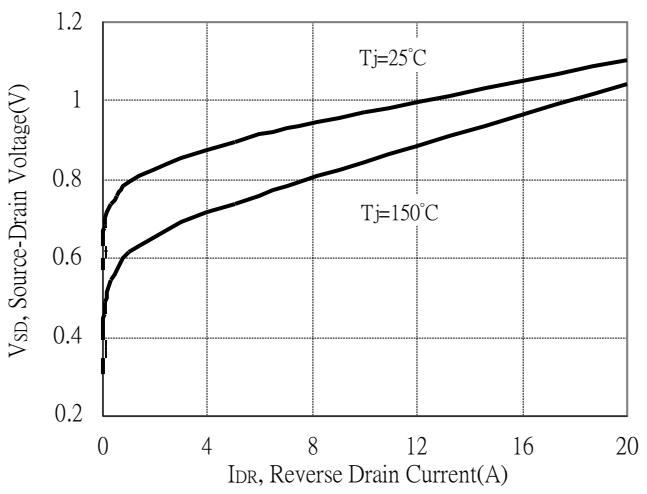
Breakdown Voltage vs Ambient Temperature



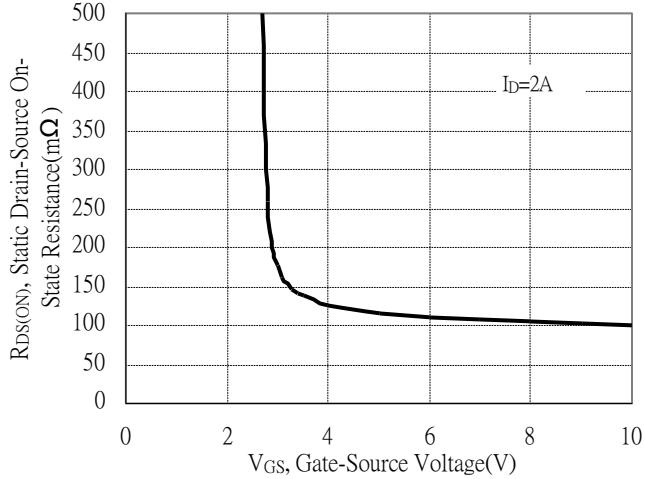
Static Drain-Source On-State resistance vs Drain Current



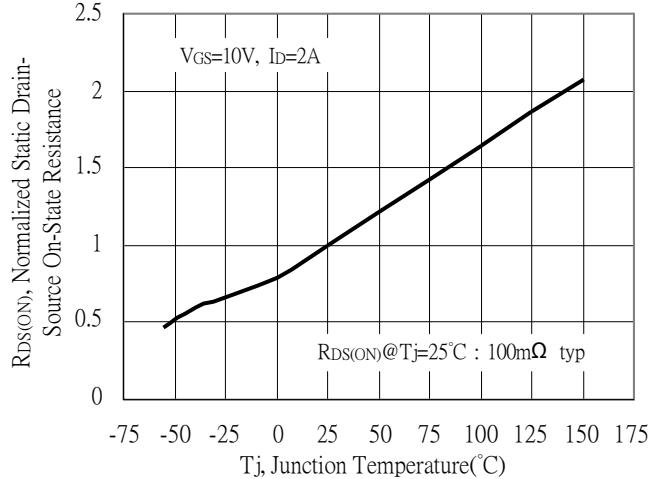
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

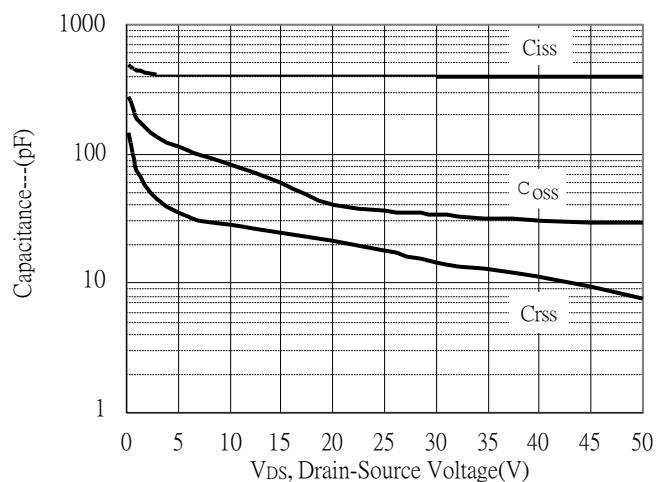


Drain-Source On-State Resistance vs Junction Temperature

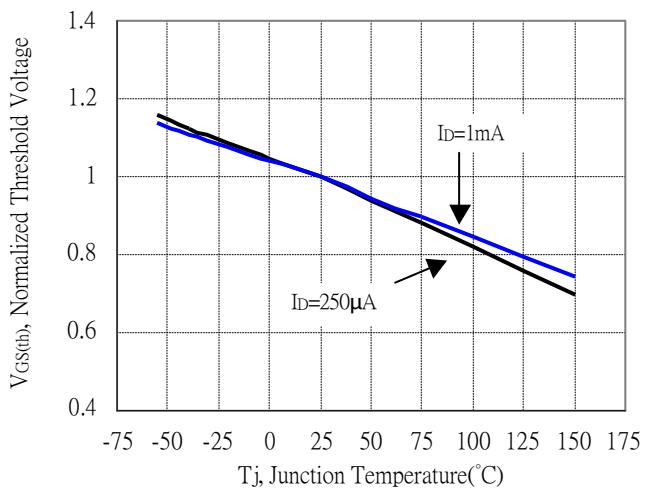


## Typical Characteristics(Cont.)

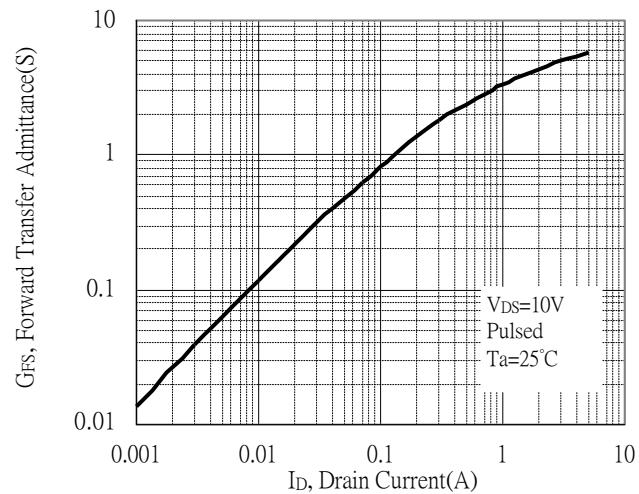
Capacitance vs Drain-to-Source Voltage



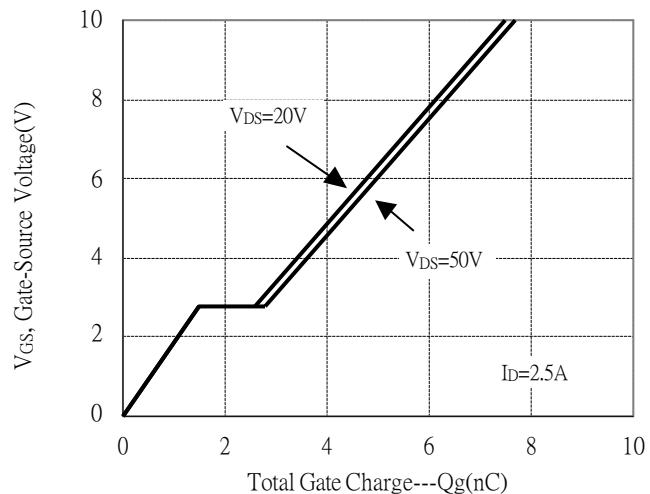
Normalized Threshold Voltage vs Junction Temperature



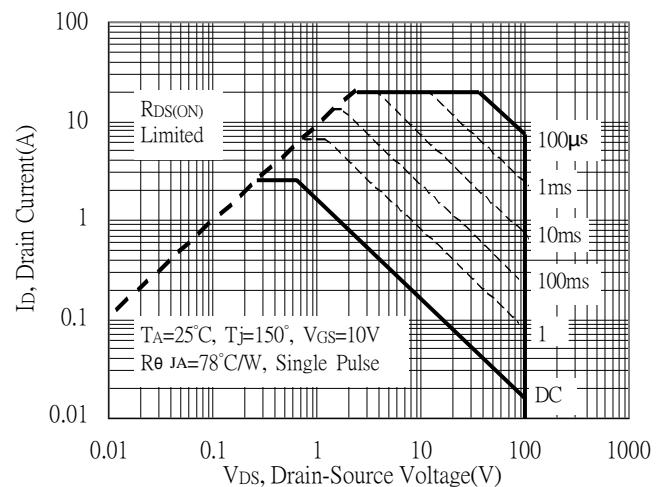
Forward Transfer Admittance vs Drain Current



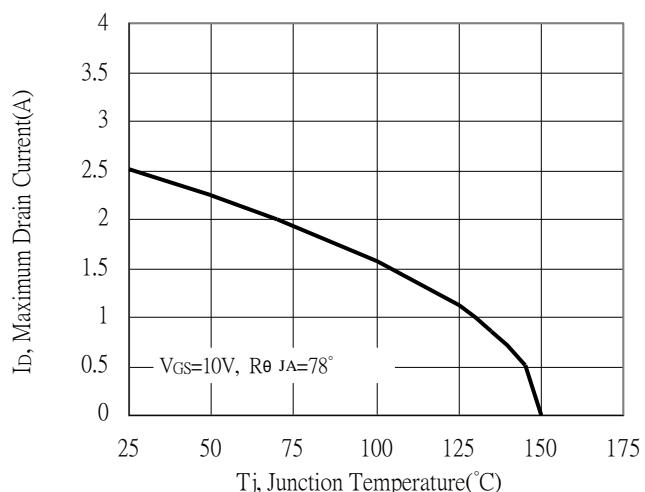
Gate Charge Characteristics



Maximum Safe Operating Area

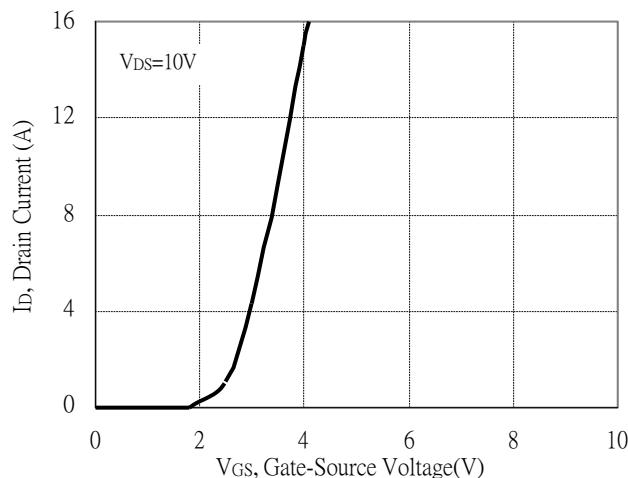


Maximum Drain Current vs Junction Temperature

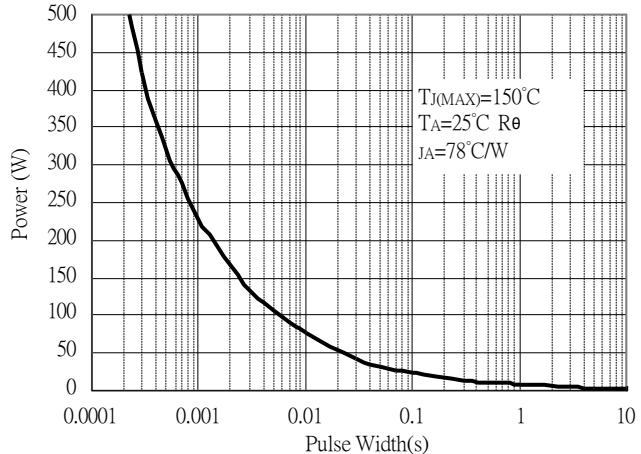


## Typical Characteristics(Cont.)

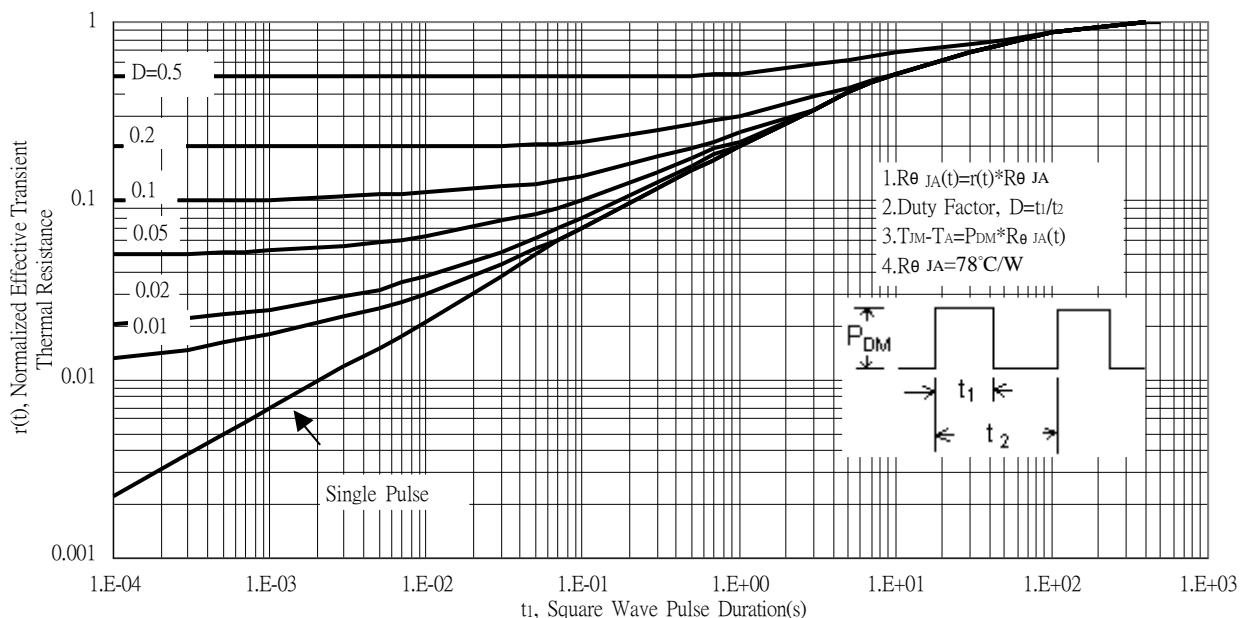
Typical Transfer Characteristics



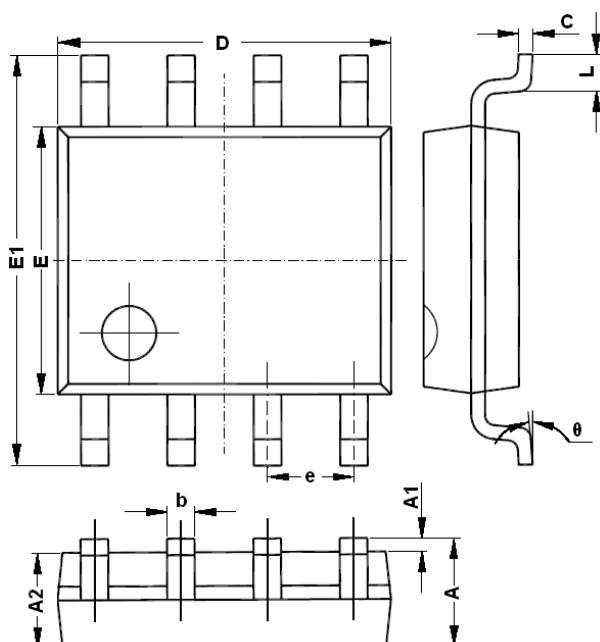
Single Pulse Maximum Power Dissipation  
 (Please see Note on page 2)



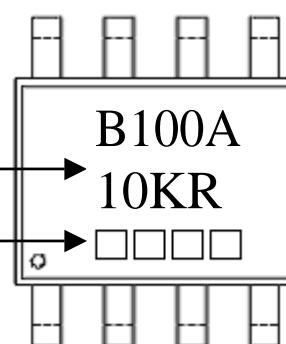
Transient Thermal Response Curves



## SOP-8 Dimension



Marking:



Device Name

Date Code

8-Lead SOP-8 Plastic Package  
Code: Q8

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	1.270 (BSC)		0.050	(BSC)
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0	8°	0	8°
D	4.700	5.100	0.185	0.200					